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ATTORNEY DOCKET NO. APPLICATION NO. FILING DATE FIRST NAMED INVENTOR **CONFIRMATION NO** 09/423,948 04/14/2000 **LEONID BERESNEV** 2345/103 7349 26646 **EXAMINER** KENYON & KENYON LLP ONE BROADWAY NGUYEN, HOAN C NEW YORK, NY 10004 ART UNIT PAPER NUMBER 2871 MAIL DATE DELIVERY MODE 07/11/2007 **PAPER** 

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

# Advisory Action Before the Filing of an Appeal Brief

	Application No.	Applicant(s)	
	09/423,948	BERESNEV ET AL.	
- 1			
	Examiner	Art Unit	

			1 -0	1 .
	The MAILING DATE of this communication appe	ars on the cover sheet with t	he correspondence add	dress
THE REI	PLY FILED <u>15 June 2007</u> FAILS TO PLACE THIS APP	PLICATION IN CONDITION FO	R ALLOWANCE.	
this pla (3)	e reply was filed after a final rejection, but prior to or or s application, applicant must time ly file one of the follo ces the application in condition for allowance; (2) a No a Request for Continued Examination (RCE) in comp owing time periods:	wing replies: (1) an amendmen ptice of Appeal (with appeal fee	it, affidavit, or other evide ) in compliance with 37 C	ence, which CFR 41.31; or
a) 🔯	The period for reply expires months from the mailing date	of the final rejection.		•
b) 🔲	The period for reply expires on: (1) the mailing date of this A event, however, will the statutory period for reply expire later	than SIX MONTHS from the mailir	ng date of the final rejection.	• •
	Examiner Note: If box 1 is checked, check either box (a) or MONTHS OF THE FINAL REJECTION. See MPEP 706.07(	(f).		
peen filed CFR 1.17 above, if c earned pa	is of time may be obtained under 37 CFR 1.136(a). The date is the date for purposes of determining the period of entsion a (a) is calculated from: (1) the expiration date of the shortened checked. Any reply received by the Office later than three most term adjustment. See 37 CFR 1.704(b).  OF APPEAL	and the corresponding amount of the statutory period for reply originally	ne fee. The appropriate extense in the final Office action	ension fee under 37 n; or (2) as set forth i
of t	e Notice of Appeal was filed on A brief in comfiling the Notice of Appeal (37 CFR 41.37(a)), or any ence a Notice of Appeal has been filed, any reply must by MENTS	xtension thereof (37 CFR 41.37	'(e)), to avoid dismissal o	of the appeal.
		but prior to the date of filing a	ariof will not be entered	Lhoouso
(a)	ne proposed amendment(s) filed after a final rejection,  They raise new issues that would require further co  They raise the issue of new matter (see NOTE belo	nsideration and/or search (see		Decause
	They are not deemed to place the application in be appeal; and/or		ly reducing or simplifying	the issues for
(d)	They present additional claims without canceling a NOTE: (See 37 CFR 1.116 and 41.33(a)).	· · · · · · · · · · · · · · · · ·	y rejected claims.	
4 🗀 T	ne amendments are not in compliance with 37 CFR 1.		n Compliant Amendmen	+ (DTOL 324)
	pplicant's reply has overcome the following rejection(s		in-Compliant Amendmen	it (1 10L-324).
3. 🔲 N	ewly proposed or amended claim(s) would be a non-allowable claim(s).	• ——	rate, timely filed amendn	nent canceling
7. 🔯 Fo	or purposes of appeal, the proposed amendment(s): a) we the new or amended claims would be rejected is pro		☑ will be entered and ar	n explanation of
	e status of the claim(s) is (or will be) as follows: aim(s) allowed:			
	ain(s) objected to:			
	aim(s) rejected: 6-16.			
	aim(s) withdrawn from consideration:			
AFFIDA'	VIT OR OTHER EVIDENCE			
be	e affidavit or other evidence filed after a final acti on, b cause applicant failed to provide a showing of good ar d was not earlier presented. See 37 CFR 1.116(e).			
9. 🔲 Th en	e affidavit or other evidence filed after the date of filing tered because the affidavit or other evidence failed to owing a good and sufficient reasons why it is necessal	overcome all rejections under a	appeal and/or appellant f	ails to provide a
	he affidavit or other evidence is entered. An explanation of the secons	on of the status of the claims a	fter entry is below or atta	iched.
	he request for reconsideration has been considered been continuation Sheet.	ut does NOT place the applicat	ion in condition for allow	ance because:
	lote the attached Information Disclosure Statement(s).	(PTO/SB/08) Paper No(s)		
13. 🔲 C	Other:	•		

Continuation of 11. does NOT place the application in condition for allowance because:

#### Response to Arguments

Applicant's arguments filed on 6/15/2007 have been fully considered but they are not persuasive.

#### Applicant's ONLY arguments are follows:

The De Lang reference does not identically describe the analyzer positioned at the output of the interferometer, the analyzer having a variable polarization state and tuning the interferometer as a function of the polarized first interference beam and the second interference beam, wherein an additional phase is introduced into at least one of the interference beams so that the interference fringe pattern is displaced by a distance.

### Examiner's responses to Applicants' ONLY arguments are follows:

The De Lang reference discloses the analyzer 10 positioned at the output of the interferometer, the analyzer having a variable polarization state (due to the intensity of the transmitted component varies sinusoidally with the angle made by the main direction of the analyzer 10 and the direction of polarization of the linearly polarized beam. The modulation depth of the transmitted radiation is 100 percent since the transmitted intensity is zero at an angle of 90 degrees between the main direction and the direction of polarization. If the circularly polarized oscillations have different amplitudes, they combine into an elliptical oscillation. The long axis of the ellipse has the direction of the linear oscillation in the case just described. The modulation depth of the radiation transmitted by the analyzer 10 varies, col. 2 lines 58 -72) and tuning the interferometer as a function of the polarized first interference beam and the second interference beam, wherein an additional phase is introduced into at least one of the interference beams so that the interference fringe pattern is displaced by a distance (due to electrical signals produced in detectors 32 -33 having a phase difference equal the optical phase difference between beams 15 and 16; the col. 3 lines 19-27).

The differences of the De Lang and the instant applications are the locations of reference surface, quarter plate and test object as Fig. 1 shown. Applicants should amended the independent claims with the locations of reference surface, quarter plate and test object to overcome the De Lang.

Adubletta Andrew Schechter Primary Examiner